

Fig. 3—Microwave absorption modulation pattern. P_1 and P_2 are the initial and absorption power levels respectively. Time scale = 0.25 μ sec/division ($E = 4000$ v/cm, 40 pps).

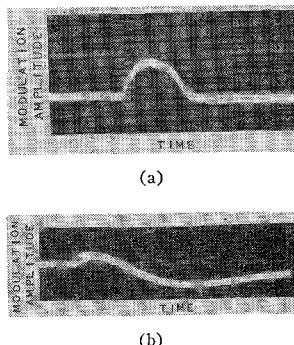


Fig. 4—Modulator operation dependence on junction polarity. Time scale = 0.5 μ second/division ($E = 2000$ v/cm, 40 pps). (a) $N-N^+$ junction connected to positive-voltage lead. (b) $N-N^+$ junction connected to negative-voltage lead.

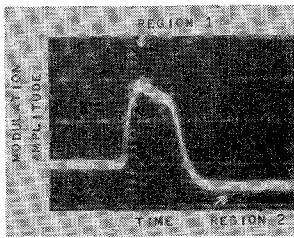


Fig. 5—Modulation changes due to minority carriers. Time scale=0.5 μ sec/division ($E = 4000$ v/cm, 40 pps).

both during and following the $0.5\text{-}\mu\text{sec}$ voltage-pulse application. This may be attributed to hole injection or to an ionization effect in these crystals. The region following the high-voltage pulse was of very long duration.

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Coaxial to Strip Transmission Line Adapter*

Over the past few years, strip transmission line has shown itself capable of being utilized in a large number of microwave configurations which were previously constructed in coaxial line or waveguide. In

many cases the components fabricated in strip transmission line are simpler to design and produce particularly where, as in the sandwich type of line, advantage may be taken of photo-etching techniques. This type of construction using copper-foil-clad dielectric material enables the foil to be used for both the center conductor and the ground planes.

However, the use of such thin conducting material with relatively poor adhesion between the metal and dielectric often leads to difficulties where the coaxial line is attached to the strip. The action of soldering the center pin of the coaxial line to the strip tends to destroy the adhesion between the foil and the dielectric. The first time the connection is made the results may be quite satisfactory, but in development work it is often necessary to assemble and dismantle a filter or other device many times to make adjustments and alterations. If a soldered connection is used in such a situation, the end of the strip is soon distorted and loosened to such an extent that measurements made through the junctions are meaningless. To overcome this difficulty, a solderless transition has been devised for use in our laboratory work. An exploded view of this transition showing the important dimensions is given in Fig. 1.

set screw in the threaded boss in the transition block holds the button tightly against the flattened pin, insuring good electrical contact between the pin and the center conductor.

The parts used for the coaxial end of the adapter were originally taken from a standard UG-1186/U connector with the body shortened and threaded as shown. However, after the initial connectors proved successful, a large quantity was made to our design by a manufacturer.

These connectors have been used over the range of frequencies from 300-6000 Mc and have given very satisfactory results. In order to confirm our opinion, measurements were made on a number of these connectors using the method of measuring a junction described by Wentworth and Barthel.¹

Six adapters, taken at random from stock, were each measured with six different lengths of strip transmission line. This involved 36 assemblies and disassemblies of the transitions, but the uniformity of the results indicated that this had no adverse effect. At any frequency and with one particular length of line, the variation of the position of the voltage minima on the slotted line was less than ± 0.2 mm with reference to the mean for the six transitions. This is of

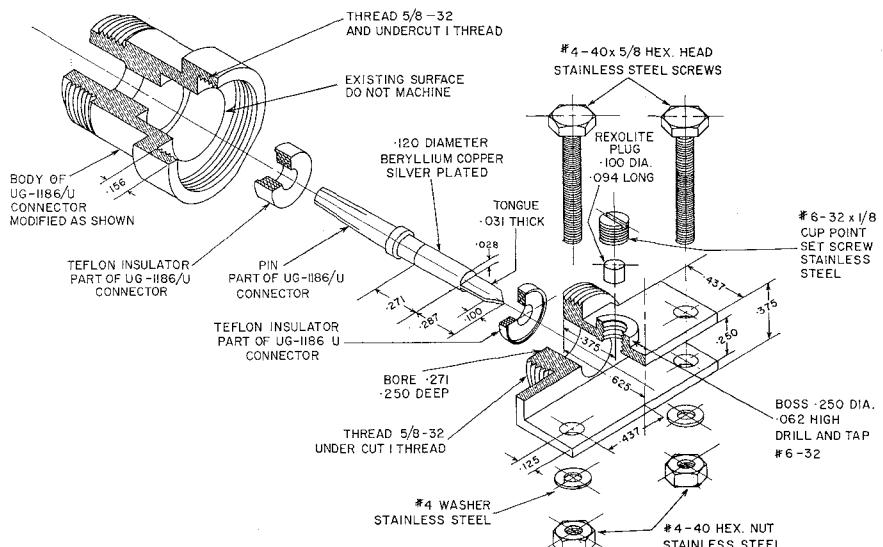


Fig. 1

The adapter could have been of either the right-angle or in-line type, but the latter was chosen for mechanical strength and convenience, in addition to the fact that a symmetrical transition is less likely to introduce spurious modes. The channelled transition block is fastened to the stripline by two machine screws. This provides the mechanical attachment and the electrical connection to the ground planes. The flattened pin is accommodated in a slot milled in the lower surface of the upper dielectric sheet. The pin is pressed against the etched center conductor by a button of the same material as the dielectric of the line which is a loose fit in a hole in the upper dielectric sheet. A

the same order as the expected experimental error and represents a spread of less than ± 0.005 wavelength at the highest frequency. This close agreement between the measurements on the various adapters enabled the mean VSWR of the junctions to be computed from the average readings (Fig. 2). The true VSWR of a particular junction would not differ from this mean value by more than ± 0.03 .

¹ F. L. Wentworth and D. R. Barthel, "A simplified calibration of two port transmission line devices," IRE TRANS. ON MICROWAVE THEORY AND TECHNIQUES, vol. MTT-4, pp. 173-175; July, 1956.

* Received by the PGMTT, December 30, 1960.

